Search Notes



Application/Control	No.

Applicant(s)/Patent under Reexamination HAMAKITA ET AI

10/796,301 Examiner

Marc A. Scharich

HAMAKITA ET AL.

3611

SEARCHED				
Class	Subclass	Date	Examiner	
See A	Hached	3/7/2007	MAS	
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INTERFERENCE SEARCHED				
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
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Additional Searching Conducted By Current Examiner	3/7/2007	MAS	
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